

**Search Notes**

Application/Control No.

10/812,105

Examiner

Andrew Lee

Applicant(s)/Patent under  
Reexamination

JEONG ET AL.

Art Unit

2416

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See EAST		12/19/2008	al

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor and Interference Search See EAST	12/19/2008	AL